

# Thermal Cycling Fatigue Life Qualification for Earth and MARS and Deep Space Mission



#### **Anupam Choubey**

Thermo-Mechanical Reliability Lead

#### John Forgrave

**Group Supervisor** 

Office of Safety and Mission Success

Jet Propulsion Laboratory, NASA

California Institute of Technology, Pasadena, CA



### **Outline**

- Mission Overview
- Thermal Environments
- Qualification Methodology
- Case Studies



### **Thermal Environments**

#### Moon



Cold: -230 C Hot: 123C



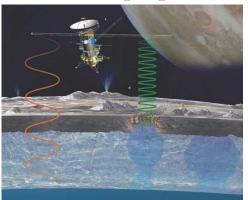
Earth Orbiter
14-16 times/day
3 – 4yrs mission
18000 cycles/seasons

#### **MARS**

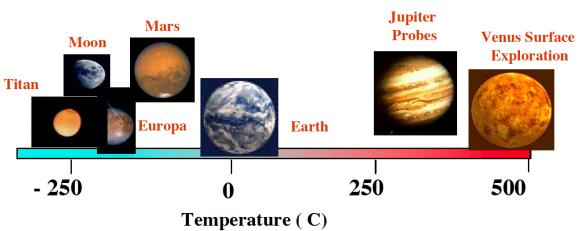


Winter Cold : -135 C Summer Hot: +70 C Mission:  $3 \sim 5$  years

#### Deep Space



Europa Clipper Cold: -240C Hot: 195C (Venus Flyby) Mission: 3 ~ 5 years







### JPL Environmental Programs

#### **Assembly/Subsystem Testing**

- Dynamic tests
  - Random vibration (include frequency survey)
  - Quasi-static loads (entry, landing)
  - Pyroshock
  - Acoustic noise (selected large area/mass)
  - Sine sweep (grinding/drilling)
- Thermal tests
  - Thermal vacuum
  - Multipacting/ionization breakdown (corona)
  - Thermal cycling life (Fatigue)
- EMC tests
  - · Conducted susceptibility/emission
  - · Radiated susceptibility/emission
  - Grounding & isolation
- Environmental analyses
  - Radiation (TID, DD, SEE)
  - Venting (pressurization & depressurization)

#### **Spacecraft System Testing**

- Dynamic tests
  - Low-level random survey
  - Random vibration
  - Quasi-static loads (Launch/entry)
  - Acoustic noise
  - Pyro firing
- Thermal tests
  - Thermal vacuum (w/ thermal balance critical h/w at FA limits during functional)
- EMC tests
  - Radiated emission
  - Radiated susceptibility
  - Self compatibility
- Environmental analyses
  - Orbital debris
  - Meteoroid (survival & shielding)
  - ESD (touch down)



## Thermal cycling Qualification Program Objectives

- Ensure the flight hardware design is capable of surviving 3X thermal cycle life.
  - Includes ground, transportation, launch, cruise, entry decent
     & landing (EDL) and mission environments.

Ensure all flight hardware (new and heritage) design has been assessed to withstand stresses from Thermal Expansion (CTE) mismatches

Ensure verification is done by heritage or testing



# Thermal Cycling Life (TCL) Packaging Qualification and Verification (PQV)

- Provides guidance early in the design to significantly reduce likelihood of failures due to thermal cycle fatigue
- Applicable to all spacecraft hardware
- Identify highest risk elements sensitive to thermal cycling fatigue, prevent escapes

Potential Concerns bonded joints composites paints New process solder joint interconnects connectors metal seals COTS adhesives bi-metallic or dissimilar material interfaces

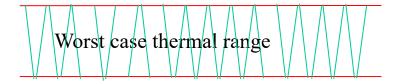




### **PQV/TCL Vs Qual Testing**

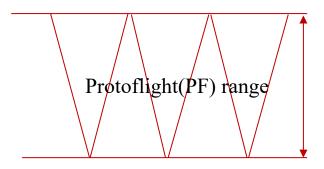
#### PQV/TCL: 3X life (Ground + Mission cycles)

- Early in the design phase
- Find Thermal Fatigue weaknesses
- Qualify a new design/process
- Coupons or design level testing
- Performed before qual testing to catch weakness early on before expensive qual testing



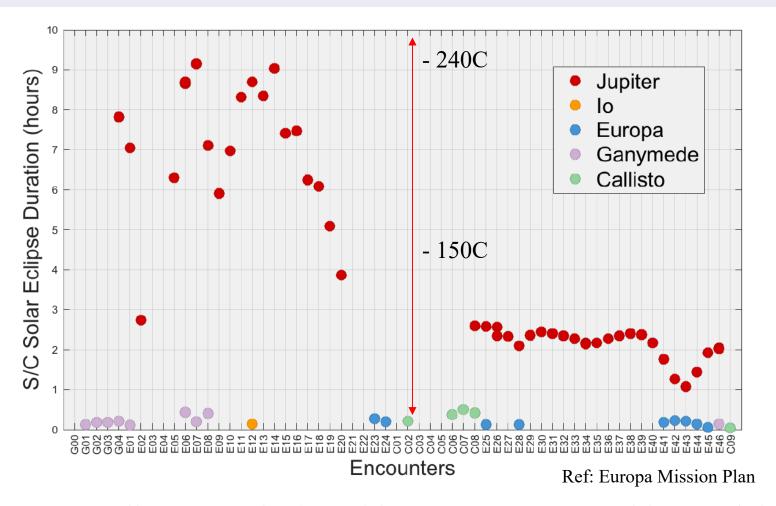
#### Qual testing (Typically 3-10 cycles)

- Find Workmanship or gross design problems
- System level (EM or flight build)
- Expensive and performed before final delivery





### Mission Plan and Thermal Environment Europa Clipper



- Long Eclipses results in colder temperatures and larger deltaT
- Are accounted while calculating thermal cycling life





### **Thermal Cycle Estimation**

|                                     |      | i         |          |              |            |
|-------------------------------------|------|-----------|----------|--------------|------------|
|                                     |      |           |          |              | 155 deltaT |
|                                     |      |           |          |              | NASA       |
| Themal Events                       |      | Worse     | Worse    | DeltaT (Hot- | Equivalen  |
|                                     | 1X   | Case Cold | Case Hot | Cold)        | t cycles   |
| Thermal event during board          |      |           |          |              |            |
| assembly (Baking, Curing)           |      |           |          |              |            |
| Ground Power On/Off cycles          | 2434 |           |          | 20           | 41         |
| Ground Thermal cycles               |      |           |          |              |            |
| Planetary protection/contamination  |      |           |          |              |            |
| control bake out                    | 1    | 25        | 120      | 95           | 0          |
| Protoflight Qual testing            | 3    | 0         | 70       |              | 0          |
| Mission Power On/Off cycles         | 206  |           |          | 20           | 3          |
| Mission Cruise + Orbit              | 120  |           |          | 50           | 12         |
| Total 1X Cycles                     |      |           |          |              | 57         |
| Total 3X Cycles                     |      |           |          |              | 170        |
| Total 3X cycles < 200 NASA handbook |      |           |          |              |            |
| •                                   |      |           |          |              |            |
| requirement Criterion (@155 deltaT) |      |           |          |              | Meets      |

#### **Generic Equivalent cycles calculation**

$$N_2 = N_1 (\Delta T_1/\Delta T_2)^m$$

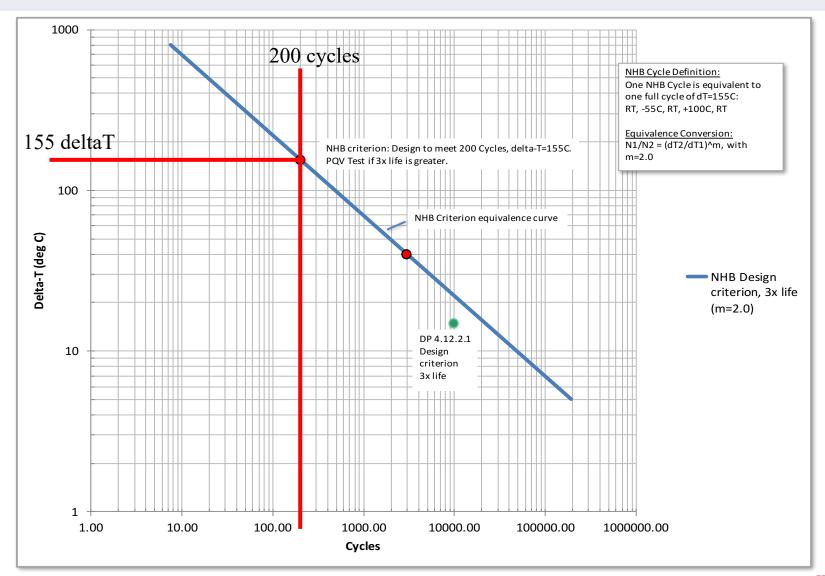
where:

- N<sub>2</sub> is the number of equivalent cycles over temperature range ΔT<sub>2</sub>
- N<sub>1</sub> is the actual number of cyclic exposures over temperature range ΔT<sub>1</sub>
- m is a property of the material being fatigued by cyclic thermal exposures
- m depends on failure mechanism (~2.0 for solder joints)





### **Thermal Cycle Criterion**







### What Needs TCL/PQV testing?

- ✓ Not all hardware goes through testing
- ✓ Hardware can be qualified by analysis or heritage review.
- ✓ Assessment is done based on set criteria to eliminate the need for testing

#### Low risk Hardware

- Thermal Environment
  - Thermal controlled/Inside the vault
  - Thermally shielded MLI blanketed hardware
  - Early deploy
  - One time operation
  - Benign cycles: 3 x cycles < NASA 200 cycles, -55C to 100C range
- Packaging and Material Review
  - Material: Purely structural
  - Heritage data applicable comparable to mission environment
  - Large design margin Robust Design





### **Packaging and Materials Aspects**

- New process (No heritage): Bake, assembly, underfills...
- New material: Adhesives change, Paints (Cryo temps)
- Technology: Plastic packages, COTS hardware...
- Component packages: Stacked components, low standoff
- Interconnects: Lead-free, Special solder
- Interfaces and composite structural elements
- Bonded joints

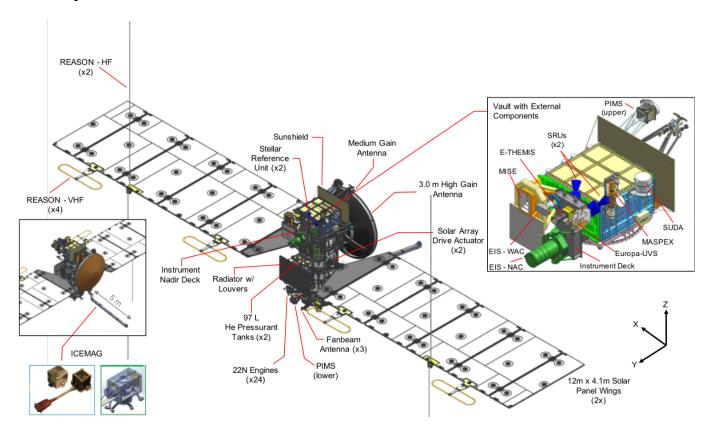




### **High Risk Thermal Environment**

#### **Thermal Environment related**

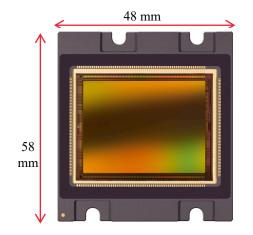
- Harsh environment (Cryogenic temperatures) (-240C) Europa Clipper
- Externally mounted Antennas, Sensors, instruments





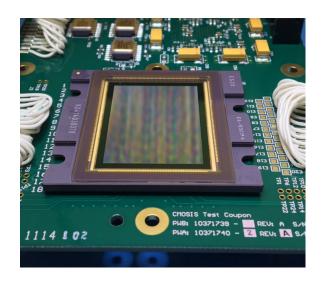


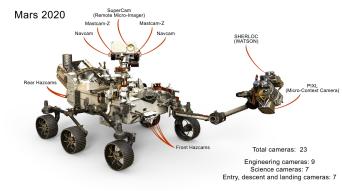
### **High Risk Cycling Environment**



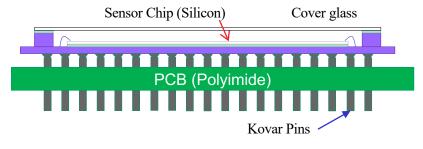
CMOSIS- 20 Megapixel Camera CMOS Image sensor (COTS-143 pin- Pin grid array)

>20 Cameras mounted on Rover – Panoramic Imaging, navigation, Hazard avoidance, Descent Imaging





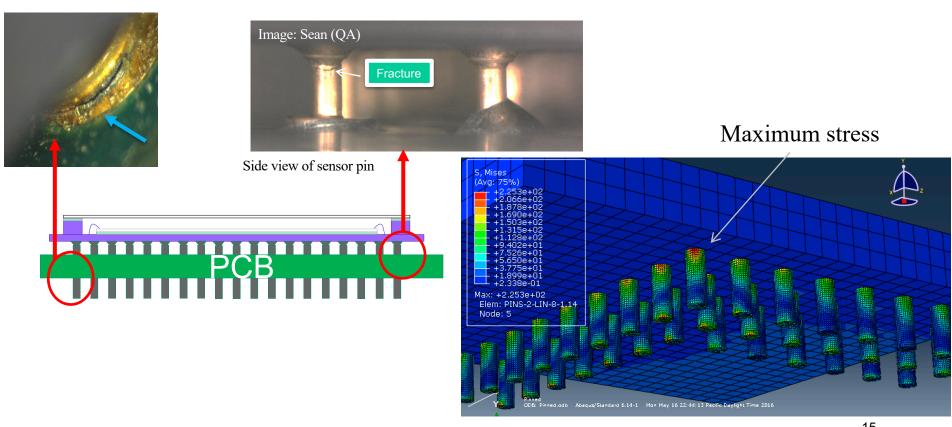
| Cycle                      | Season   | Low<br>(°C) | High (°C) | ΔT (°C) | No.<br>Cycles |
|----------------------------|----------|-------------|-----------|---------|---------------|
| Accelerated Risk Reduction |          | -135        | +70       | 205     | 1530          |
| Mars2020 PQV               | Summer   | -105        | 40        | 145     | 2115          |
|                            | Winter   | -135        | 15        | 145     | 900           |
| Modified                   | Summer   | -80         | +50       | 130     | 2115          |
| Seasonal                   | Winter 1 | -115        | -10       | 105     | 450           |
| Cycles                     | Winter 2 | -110        | 20        | 130     | 450           |







- CTE mismatch causing excessive stress on corner pins resulting in fracture
- **Risk Reduction activity** 
  - Design and assembly changes results in reduced stress and survive 3X life





## **Summary**

- Environmental Program has been an integral part of JPL missions
- Thermal Cycling Program has been added as part of design rules for all hardware to meet 3X life
- 3X life requirement has proved to be sufficient to survive mission environment
  - Mars Rover Working > 5X life
- With more and more vendors delivering hardware for JPL missions, thermal cycling life program ensures long term reliability of hardware